



Face Recognition and Its Applications

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Message from the Guest Editors

The human face brings with its appearance and shape a number of clues enabling the extraction of information about person identity, gender, age, ethnicity, health, emotional state and physical wellness, to name but a few. Face recognition has a critical role in biometric systems and is attractive for numerous applications including visual surveillance and security, medical imaging, and affective computing. Vigorous research is needed to solve such outstanding challenging problems and propose advanced solutions and systems for emerging applications of facial image processing and analysis.

Topics of interest include, but are not limited to, the following:

- Face and feature detection
- Pre-processing methods
- New sensors or data sources
- Data set and evaluation
- Machine learning and deep learning
- Applications of face recognition





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Message from the Editor-in-Chief

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